

**Search Notes**

Application/Control No.

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Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

PURCELL ET AL.

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
708	300, 256, 253	7/1/2005	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see attached copy) Check references of Div. 10/711,115	7/1/2005	MAI